CONTINUE

NPIC/TSSG/ESD-26-68 9 October 1968

MEMORANDUM FOR: Chie	ef, Developme	ent and Eng	ineering Division	n, TSSG
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SUBJECT: Desi

Design Problems on

Chip Comparator

1. The attached documents describe engineering design problems encountered during maintenance of Chip Comparators now in operational use. This information is forwarded for any action that you consider to be appropriate. We would like to be informed of the course of action that results.

2. We hope to continue to provide this type of design related information with the objective of assisting DED in improving the maintainability and reliability of exploitation equipment. Since ESD technical maintenance personnel in their normal duties are in frequent contact with the equipment users they are most likely to be familiar with equipment maintainability and reliability problems. Recommendations for correction of deficiencies will be included whenever possible.

Chief, Engineering Support Division, TSSG

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